

Search Notes

Application/Control No.

10/760,456

Examiner

Ellen C. Tran

Applicant(s)/Patent under
Reexamination

OHARA ET AL.

Art Unit

2134

SEARCHED

Class	Subclass	Date	Examiner
713	176	1/19/2008	ET
713	193	1/19/2008	ET
726	32	1/19/2008	ET

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	1/19/2008	ET
NPL - IEEE XPLORE	1/19/2008	ET
ALL CLAIMS WERE REVIEWED FOR POSSIBLE 101 REJECTIONS	1/19/2008	ET